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Inventor: Yoshiaki Nagashima et al.
Title: NONDESTRUCTIVE INSPECTION APPARATUS AND
NONDESTRUCTIVE INSPECTION METHOD USING

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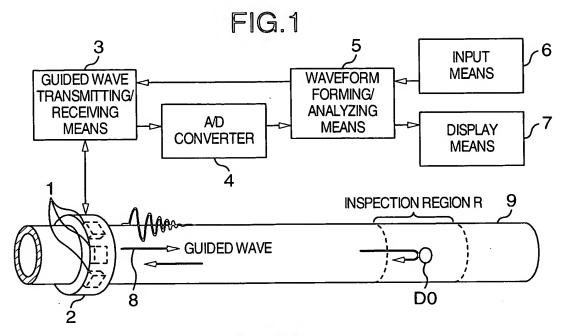


FIG.2

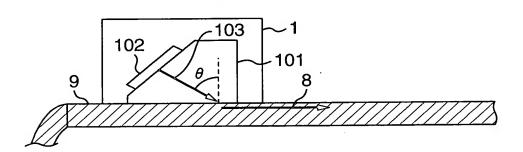
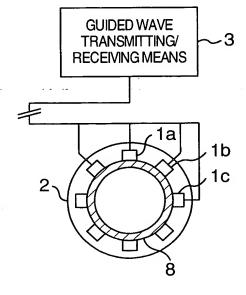


FIG.3



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## FIG.4A

INSPECTION CONDITION SETTING WINDOW	
PIPE WALL THICKNESS OF PIPE ARRANGEMENT 6 mm	
MATERIAL CARBON STEEL STAINLESS STEEL ALUMINUM	
SOUND VELOCITY OF 55940 m/s	
SOUND VELOCITY OF 3260 m/s	
INSPECTION 500 mm ~ 1500 mm (DISTANCE FROM ELEMENT)	

FIG.4B

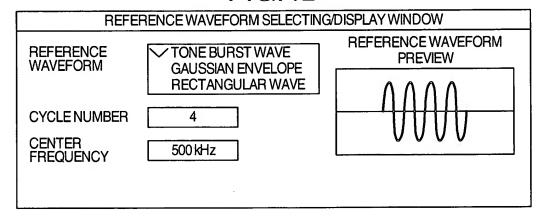
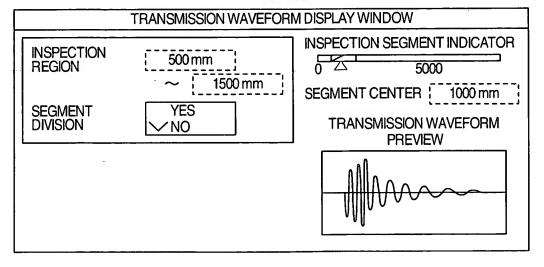


FIG.5



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FIG.8

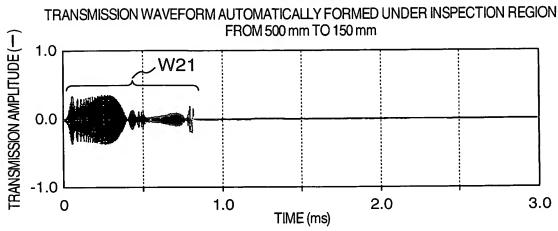
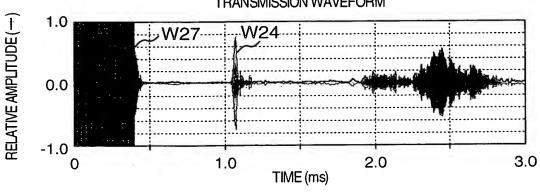


FIG.9A INSPECTION RESULT USING NORMAL TRANSMISSION WAVEFORM 64 0.10 SIGNAL AMPLITUDE (V) <u>63</u> 0.05 0.0 -0.05 -1.0 1.0 3.0 2.0 0 TIME (ms)

FIG.9B
INSPECTION RESULT USING AUTOMATICALLY FORMED TRANSMISSION WAVEFORM



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FIG.10A

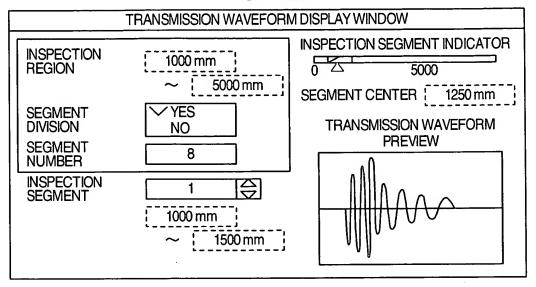
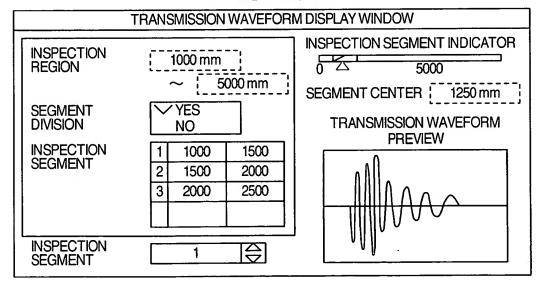
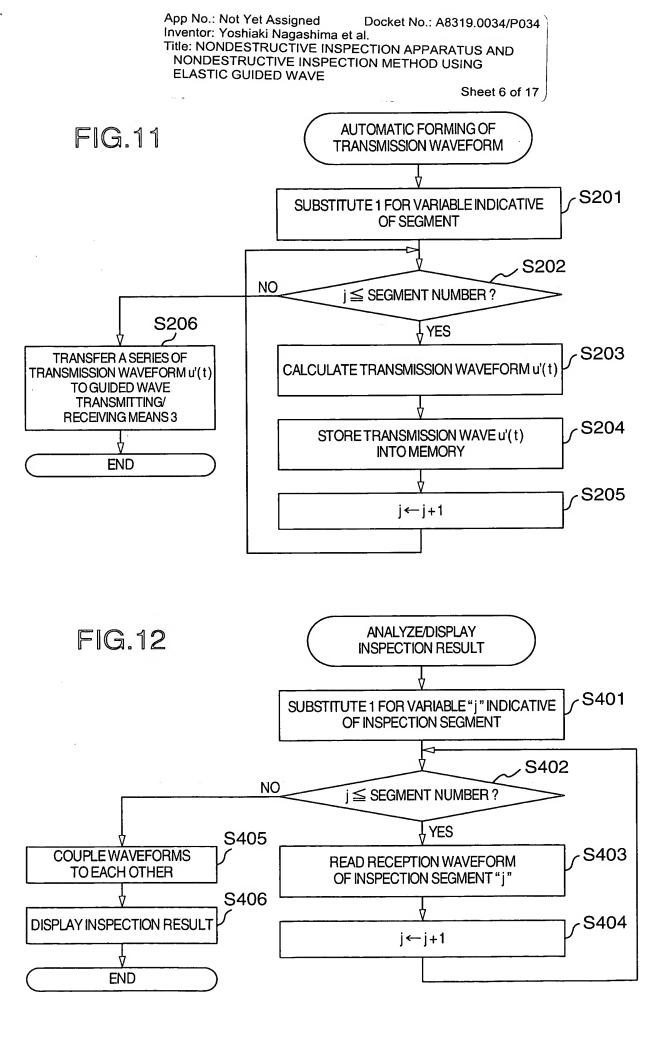


FIG.10B





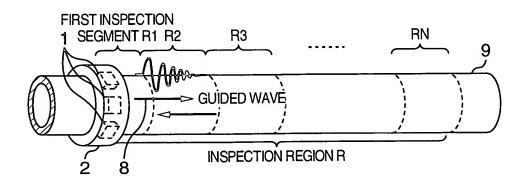
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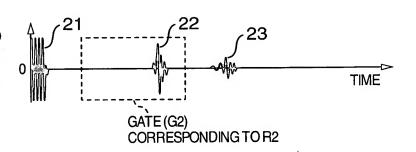
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# FIG.13A



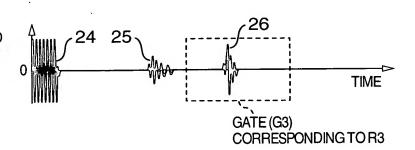
# FIG.13B

RECEPTION WAVEFORM RECEIVED WHEN TRANSMISSION WAVEFORM HAVING HIGH SENSITIVITY WITH RESPECT TO SECOND INSPECTION SEGMENT (R2) IS APPLIED TO GUIDED WAVE TRANSMITTING/RECEIVING ELEMENT 1



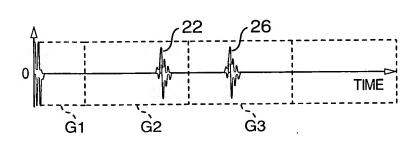
# FIG.13C

RECEPTION WAVEFORM RECEIVED WHEN TRANSMISSION WAVEFORM HAVING HIGH SENSITIVITY WITH RESPECT TO THIRD INSPECTION SEGMENT (R3) IS APPLIED TO GUIDED WAVE TRANSMITTING/RECEIVING ELEMENT 1



## FIG.13D

**COUPLED WAVEFORM** 



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FIG.14A

TRANSMISSION WAVEFORM IN WHICH REFLECTION WAVE FROM POSITION OF DISTANCE 500 mm BECOMES HIGH AMPLITUDE

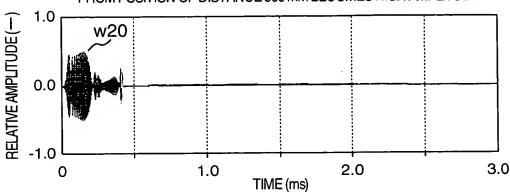


FIG.14B

TRANSMISSION WAVEFORM IN WHICH REFLECTION WAVE FROM POSITION OF DISTANCE 1000 mm BECOMES HIGH AMPLITUDE

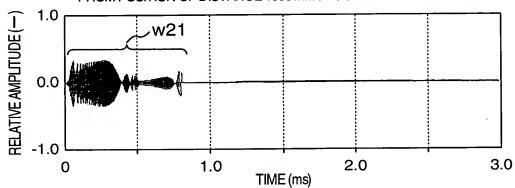
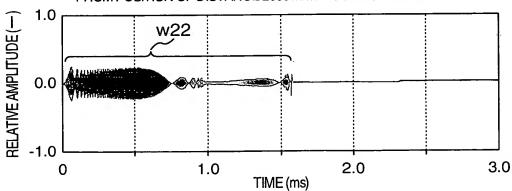


FIG.14C

TRANSMISSION WAVEFORM IN WHICH REFLECTION WAVE FROM POSITION OF DISTANCE 2000 mm BECOMES HIGH AMPLITUDE



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## FIG.15A

REFLECTION WAVEFORM REFLECTED FROM DEFECT LOCATED AT POSITION
BY DISTANCE 500 mm IN CASE THAT TRANSMISSION WAVEFORM IS TRANSMITTED IN WHICH
REFLECTION WAVE REFLECTED FROM POSITION BY DISTANCE 500 mm BECOMES HIGH AMPLITUDE

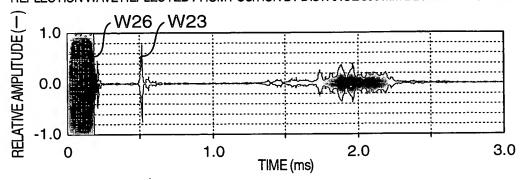


FIG.15B

REFLECTION WAVEFORM REFLECTED FROM DEFECT LOCATED AT POSITION
BY DISTANCE 1000 mm IN CASE THAT TRANSMISSION WAVEFORM IS TRANSMITTED IN WHICH
REFLECTION WAVE REFLECTED FROM POSITION BY DISTANCE 1000 mm BECOMES HIGH AMPLITUDE

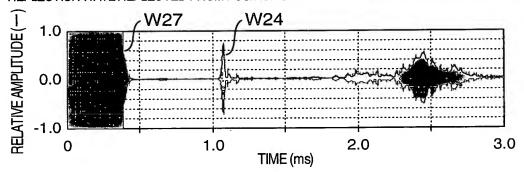
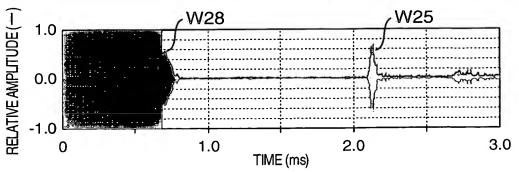


FIG.15C

REFLECTION WAVEFORM REFLECTED FROM DEFECT LOCATED AT POSITION BY DISTANCE 2000 mm IN CASE THAT TRANSMISSION WAVEFORM IS TRANSMITTED IN WHICH REFLECTION WAVE REFLECTED FROM POSITION BY DISTANCE 2000 mm BECOMES HIGH AMPLITUDE



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FIG.16

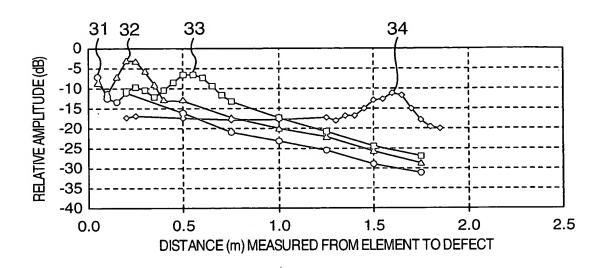


FIG.17A

DISPERSION AMPLITUDE **CORRECTION CURVE** 

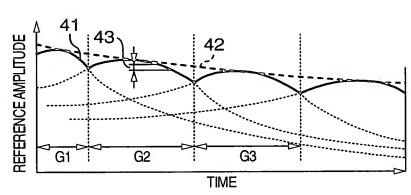
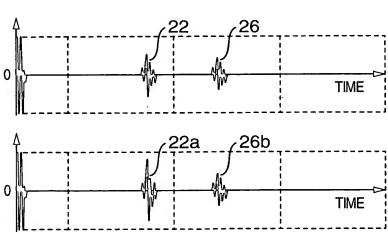


FIG.17B

**COUPLED WAVEFORM** 

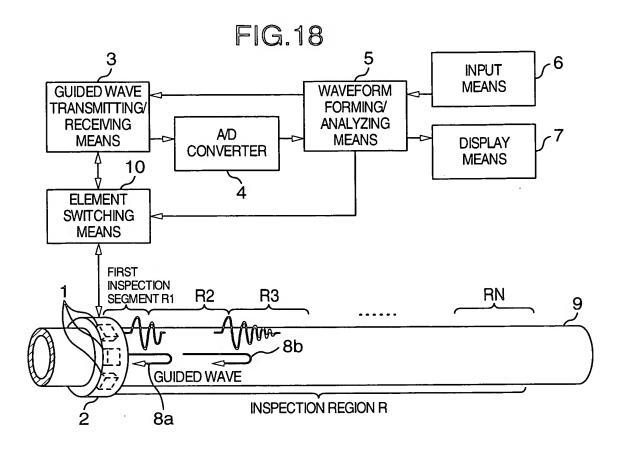
FIG.17C

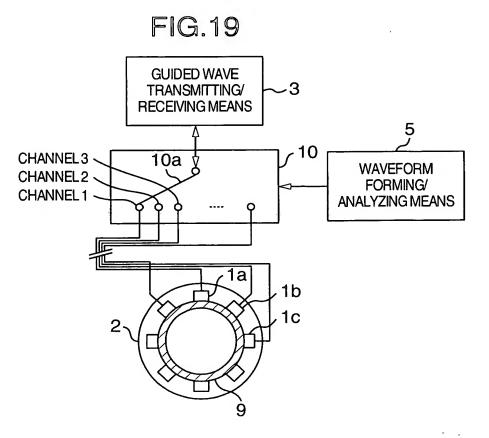
**COUPLED WAVEFORM AFTER** DISPERSION AMPLITUDE **CORRECTION** 



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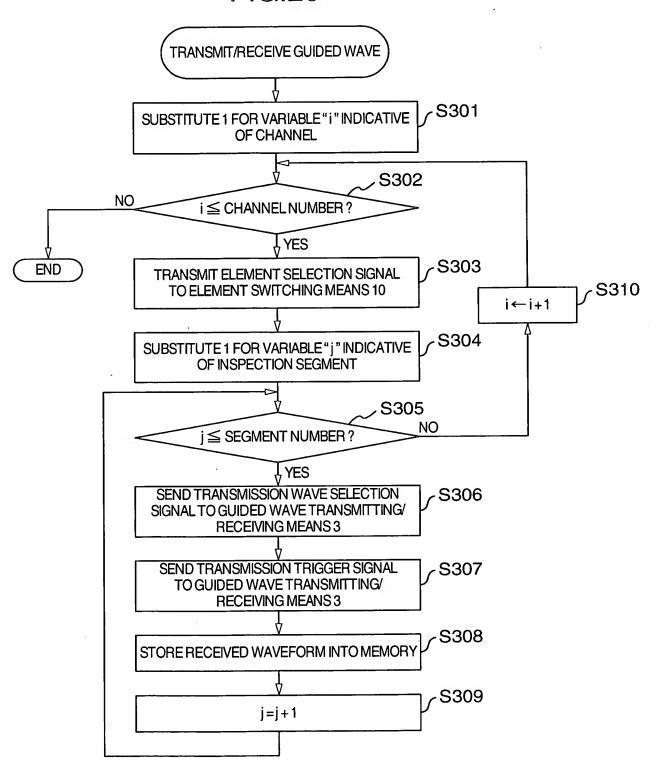


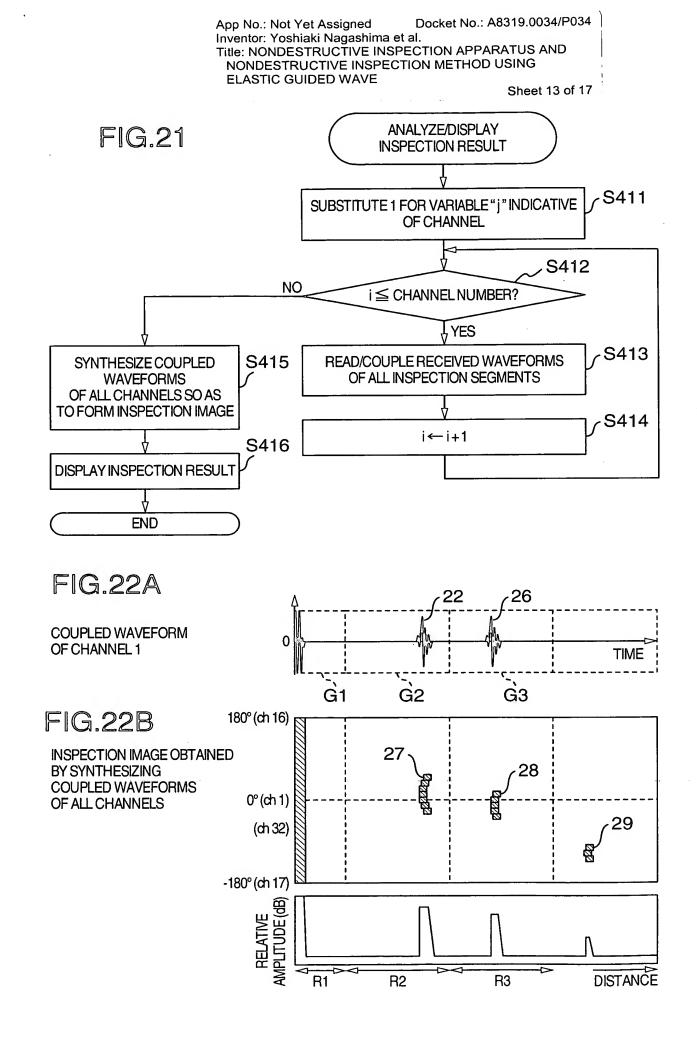


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# FIG.20





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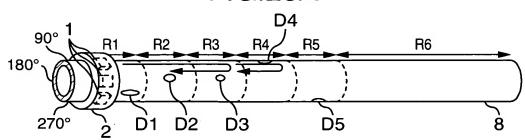
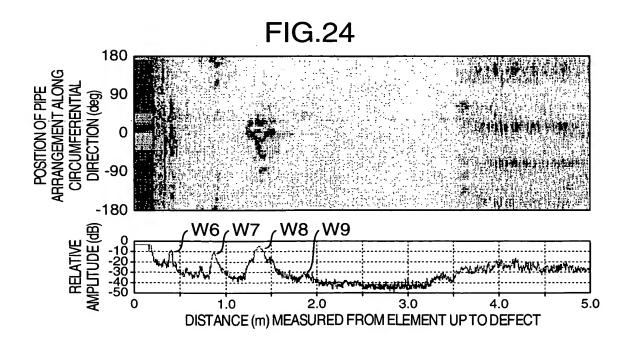


FIG.23B 180 ARRANGEMENT ALONG CIRCUMFERENTIAL DIRECTION (deg) POSITION OF PIPE 90 0 -90 -180 RELATIVE 2.0 5.0 0 3.0 4.0 DISTANCE (m) MEASURED FROM ELEMENT UP TO DEFECT



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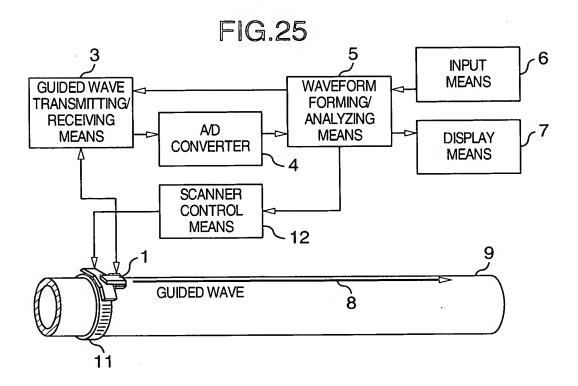
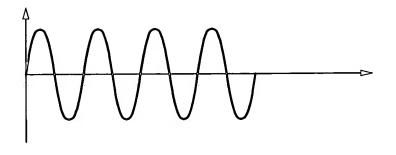


FIG.26

TONE BURST WAVE (EXAMPLE OF 4 CYCLES)



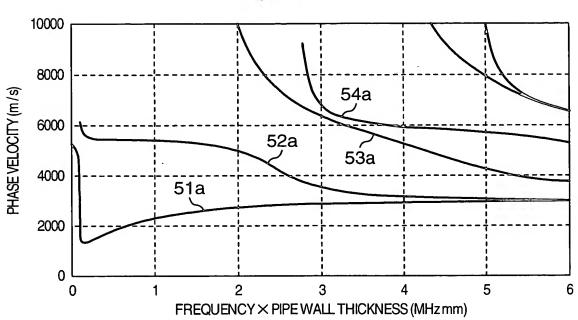
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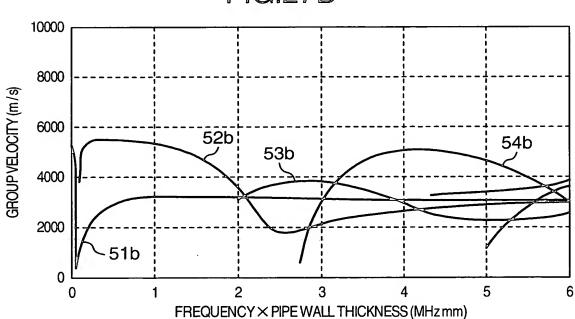
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# FIG.27B



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FIG.28

